

Product Change Notification - CSI0500065 - JAON-08AHID607

Date:

08 Apr 2019 **Product Category:** Switching Regulators

Affected CPNs:

7

Notification subject:

CCB 1737.10 Final Notice: Release to production of listed Micrel Regulator product type manufactured with the CSI05 process technology to Microchip Fab.

Notification text:

PCN Status:

Final Notification

Note: This final PCN only pertains to the products listed in this PCN. Additional final PCNs may be issued for this combination of product type and process technology.

PCN Type:

Manufacturing Change

Microchip Parts Affected:

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Release to production of listed Micrel Regulator product type manufactured with the CSI05 process technology to Microchip Fab.

NOTE: Please review the FAQ linked <u>here</u> for additional information about this change.

Pre Change:

Fabricated at Micrel fabrication site (San Jose, CA, USA) using 6 inch wafers.

Post Change:

Fabricated at Microchip fabrication site using 8 inch wafers.

Pre and Post Change Summary:

	Pre Change	Post Change
	Micrel fabrication site	
Fab Site		Microchip fabrication site
	(San Jose, CA, USA)	
Wafer Size	6 inch wafers	8 inch wafers

Impacts to Data Sheet:

None

Reason for Change:

To improve productivity with the closure of the Micrel fab as part of the integration of Micrel and Microchip.

Change Implementation Status:

In Progress

Estimated First Ship Date:

Estimated First Ship Date (EFSD) are identified for each catalog part numbers (CPN) listed in the attached parts list. This can be found in the attachments field below labeled as PCN_#_Affected_CPN.



Summary Time Table of notable events to date:

	S	Sep 2	ter 201	nbe 5	ər	->		Sep 2	oten 201	nbe 6	r	->		Apr	ril 20			->		Ma	ay 20	19	
Workweek	36	37	38	39	40		35	36	37	38	39		14	15	16	17	18		18	19	20	21	22
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Issue Date																							
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31JLEX869																							
Qual Report																							
Available																							
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JAON-																							
08AHID607																							
Final PCN																							
Issue Date																							
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Markings to Distinguish Revised from Unrevised Devices:

Traceability code and shipping label see <u>FAQ</u>.

Revision History:

September 1, 2015: Issued initial notification as PCN number CYER-31JLEX869.

September 25, 2016: Issued intermediate notification as PCN number <u>JAON-08AHID607</u>. Attached the Qualification Report. Revised the estimated first ship date (EFSD) to inform that the EFSD will be revealed in the final PCN.

April 08, 2019: Issued final notification as PCN number JAON-08AHID607-CSI0500065 for listed Micrel Regulator product manufactured with the CSI05 process technology. Provided estimated first ship date (EFSD) for each CPN listed in the attached parts list.

The change described in this PCN does not alter Micrel's or Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s):

PCN_JAON-08AHID607-CSI0500065_Affected_CPN.pdf PCN_JAON-08AHID607-CSI0500065_Qual_Report.pdf PCN_JAON-08AHID607-CSI0500065_Affected_CPN.xls

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.



Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN home page</u> select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

JAON-08AHID607 - CCB 1737.10 Final Notice: Release to production of listed Micrel Regulator product type manufactured with the CSI05 process technology to Microchip Fab.

Affected Catalog Part Numbers (CPN)

MIC2207YML-TR

JAON-08AHID607-CSI0500065 - CCB 1737.10 Final Notice: Release to production of listed Micrel Regulator product type manufactured with the CSI05 process technology to Microchip Fab.

Affected Catalog Part Numbers (CPN)

PCN_JAON-08AHID607-CSI0500065							
CATALOG_PART_NBR Estimated First Ship Date (EFSD)							
MIC2207YML-TR	May 16, 2019						



QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: JAON-08AHID607-CSI0500065

Date September 20, 2016

Qualification of Microchip 8 inch Fabrication site for Micrel products manufactured with the CSI05 Process Technology.

PART NUMBER	PACKAGE TYPE	ASSEMBLY LOCATION	FAB LOCATION	PROCESS NAME
MIC23250-S4YMT-TR	DFN22-10L	UNISEM, IPOH, MALAYSIA	MICROCHIP FAB-2 TEMPE AZ.	CSI 0.5

DIE QUALIFICATION RESULTS

TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	168 HR Rej/ss	500 HR Rej/ss	1000 HR Rej/ss	COMMENTS
HTOL	JESD22, Method 108	1609	V216328088.100MQB	0/77	0/77	0/77	
High Temperature Operating Life Test	Ta = + 125°C	1606	V216328088.000MQJ	0/77	0/77	0/77	
	Vcc = +5.5V	1606	V216328088.000MQK	0/77	0/77	0/77	

ELECTROSTATIC DISCHARGE

TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	STRESS	RESULT Rej/ss	COMMENTS	
ESD-HBM Human Body Model ATE Test @ Room +25C	R= 1500 Ohms C= 100 pF 1X +/- Voltage	1609	V216328088.100MQB	+/-2000V	0/3	Note: ESD ratings are device specific. All Products qualified on the 8" Micrel process technologies will have the same or better ESD and Latch-up performance as the 6" San Jose Products.	
ESD-CDM Charged Device Model ATE Test @ Room +25C	JESD22-C101 1X +/- Voltage	1609	V216328088.100MQB	+/-1500V	0/3		
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	STRESS	RESULT Rej/ss	COMMENTS	
LATCH-UP	JESD-78 TA = +25°C	1609	V216328088.100MQB	i/o lu o/v lu	0/6 0/6		

PACKAGE QUALIFICATION RESULTS

TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	Rej/ss	COMMENTS			
Level 1		1609	V216328088.100MQB	0/323				
Pre-conditioning Flow	JESD22-A113	1606	V216328088.000MQJ	0/143				
		1606	V216328088.000MQK	0/143				
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	96 HR Rej/ss	COMMENTS			
PRESSURE POT	JESD22-A102	1609	V216328088.100MQB	0/45				
With Level 1 Pre- conditioning	Ta = +121°C/100%RH	1606	V216328088.000MQJ	0/45				
Tpeak + 260°C 3X Reflow	15 PSIG	1606	V216328088.000MQK	0/45				
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	96 HR Rej/ss	COMMENTS			
HAST	JESD22-A110 (BIASED)	1609	V216328088.100MQB	0/45				
With Level 1 Pre- conditioning	Ta= +130°C/85%RH	1606	V216328088.000MQJ	0/45				
Tpeak + 260°C 3X Reflow	Vcc = +5.5V	1606	V216328088.000MQK	0/45				
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	500 CY Rej/ss	COMMENTS			
TEMP CYCLE	JESD22-A104	1609	V216328088.100MQB	0/45				
With Level 1 Pre- conditioning	Ta = -65°C / +150°C	1606	V216328088.000MQJ	0/45				
Tpeak + 260°C 3X Reflow		1606	V216328088.000MQK	0/45				
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	1000 HR Rej/ss	COMMENTS			
HTSL								
High Temperature Storage Life	JESD22-A103	1609	V216328088.100MQB	0/76				
With Level 1 Pre- conditioning Tpeak + 260°C 3X Reflow	Ta = +150°C							
FLAMMABILITY	UL-94V-0	All mold control for the second secon	ompounds used by Micrel m ammability certifications M	neet this standa	ard. See the UL website on-line list of Certificate of Compliance from the			
	Certified	material flammability certifications. Micrel requires a Certificate of Compliance from the assembly house and we verify the certifications on the web.						